TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCX16245FT

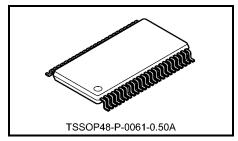
Low-Voltage 16-Bit Bus Transceiver with 3.6-V Tolerant Inputs and Outputs

The TC74VCX16245FT is a high-performance CMOS 16-bit bus transceiver. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to 3.6 $\rm V.$

This 16-bit bus transceiver is controlled by direction control (DIR) inputs and output enable $(\overline{\text{OE}})$ inputs which are common to each byte. It can be used as two 8-bit transceivers or one 16-bit transceiver. The direction of data transmission is determined by the level of the DIR inputs. The $\overline{\text{OE}}$ inputs can be used to disable the device so that the busses are effectively isolated.

All inputs are equipped with protection circuits against static discharge.



Weight: 0.25 g (typ.)

Features (Note)

- Low-voltage operation: V_{CC} = 1.8 to 3.6 V
- High-speed operation: t_{pd} = 2.5 ns (max) (V_{CC} = 3.0 to 3.6 V)

: t_{pd} = 3.0 ns (max) (V_{CC} = 2.3 to 2.7 V)

 $: t_{pd} = 5.0 \text{ ns (max) (V}_{CC} = 1.8 \text{ V})$

Output current: I_{OH}/I_{OL} = ±24 mA (min) (V_{CC} = 3.0 V)

 $: I_{OH}/I_{OL} = \pm 18 \text{ mA (min)} (V_{CC} = 2.3 \text{ V})$

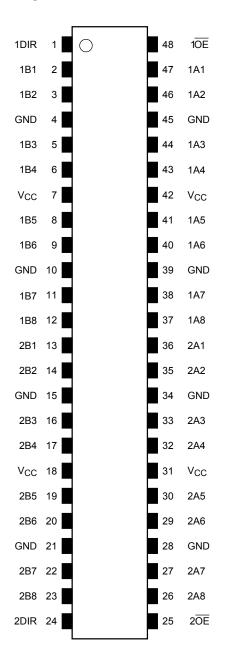
 $: I_{OH}/I_{OL} = \pm 6 \text{ mA (min) (V}_{CC} = 1.8 \text{ V)}$

- Latch-up performance: –300 mA
- ESD performance: Machine model ≥ ±200 V
 Human body model ≥ ±2000 V
- Package: TSSOP
- Bidirectional interface between 2.5 V and 3.3 V signals.
- . 3.6-V tolerant function and power-down protection provided on all inputs and outputs

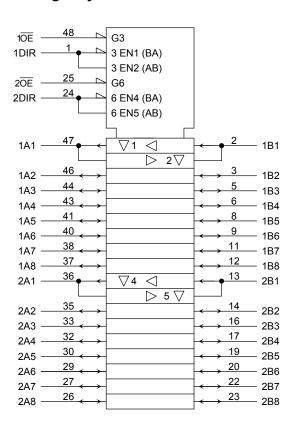
Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

All floating (high impedance) bus pins must have their input level fixed by means of pull-up or pull-down resistors.

Pin Assignment (top view)



IEC Logic Symbol



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Truth Table

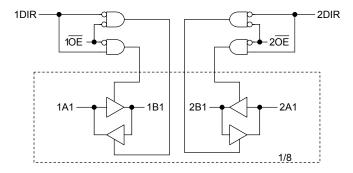
Inp	outs	Function		
1OE	1DIR	Bus 1A1-1A8	Bus 1B1-1B8	Outputs
L	L	Output	Input	A = B
L	Н	Input	Output	B=A
Н	Х	Ž	Z	

Inp	outs	Func	ction	
2 OE	2DIR	Bus Bus 2A1-2A8 2B1-2B8		Outputs
L	L	Output	Input	A = B
L	Н	Input	Output	B = A
Н	Х	Ž	7	Z

X: Don't care

Z: High impedance

System Diagram





Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	Vcc	−0.5 to 4.6	V
DC input voltage (DIR, $\overline{\text{OE}}$)	V _{IN}	-0.5 to 4.6	٧
		-0.5 to 4.6 (Note 2)	
DC bus I/O voltage	V _{I/O}	-0.5 to V _{CC} + 0.5	V
		(Note 3)	
Input diode current	I _{IK}	-50	mA
Output diode current	lok	±50 (Note 4)	mA
DC output current	lout	±50	mA
Power dissipation	P_{D}	400	mW
DC V _{CC} /ground current per supply pin	I _{CC} /I _{GND}	±100	mA
Storage temperature	T _{stg}	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	Vcc	1.8 to 3.6	V
Fower supply voltage	VCC	1.2 to 3.6 (Note 2)	V
Input voltage (DIR, \overline{OE})	V _{IN}	-0.3 to 3.6	V
Bus I/O voltage	Viva	0 to 3.6 (Note 3)	V
Bus I/O voltage	V _{I/O}	0 to V _{CC} (Note 4)	V
		±24 (Note 5)	
Output current	I _{OH} /I _{OL}	±18 (Note 6)	mA
		±6 (Note 7)	
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs and bus inputs must be tied to either VCC or GND. Please connect both bus inputs and the bus outputs with VCC or GND when the I/O of the bus terminal changes by the function. In this case, please note that the output is not short-circuited.

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Note 2: Data retention only

Note 3: OFF state

Note 4: High or low state

Note 5: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$

Note 6: $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$

Note 7: $V_{CC} = 1.8 \text{ V}$

Note 8: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V



Electrical Characteristics

DC Characteristics (Ta = -40 to 85°C, 2.7 V < $V_{CC} \le 3.6$ V)

Characteristics		Symbol	Test (Condition		Min	Max	Unit		
					V _{CC} (V)					
Input voltage	H-level	V_{IH}		_	2.7 to 3.6	2.0		V		
input voltage	L-level	V_{IL}		_	2.7 to 3.6		0.8	v		
				$I_{OH} = -100 \mu A$	2.7 to 3.6	V _{CC} - 0.2	_			
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	$I_{OH} = -12 \text{ mA}$	2.7	2.2	_			
				I _{OH} = -18 mA	3.0	2.4	_			
Output voltage				I _{OH} = -24 mA	3.0	2.2	_	V		
		.,	$V_{IN} = V_{IH}$ or V_{IL}	I _{OL} = 100 μA	2.7 to 3.6	_	0.2			
	L-level			I _{OL} = 12 mA	2.7	_	0.4			
	L-ievei	V _{OL}		AIV = AIH OI AIT	AIN = AIH OI AIL	I _{OL} = 18 mA	3.0	_	0.4	
				I _{OL} = 24 mA	3.0	_	0.55			
Input leakage current	•	I _{IN}	V _{IN} = 0 to 3.6 V	•	2.7 to 3.6	_	±5.0	μА		
0 -t-ttt 0FF -t	-4		$V_{IN} = V_{IH}$ or V_{IL}	$V_{IN} = V_{IH}$ or V_{IL}			140.0	^		
3-state output OFF state current		loz	V _{OUT} = 0 to 3.6 V		2.7 to 3.6		±10.0	μΑ		
Power-off leakage cu	rrent	l _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0		10.0	μА		
Outles cont avenuely avenuent			V _{IN} = V _{CC} or GND		2.7 to 3.6	_	20.0			
Quiescent supply cur	eni	Icc	$V_{CC} \leqq (V_{IN},V_{OUT}) \leqq$	$C \le (V_{IN}, V_{OUT}) \le 3.6 \text{ V}$			±20.0	μΑ		
Increase in I _{CC} per in	put	Δlcc			2.7 to 3.6	_	750			

DC Characteristics (Ta = -40 to 85°C, 2.3 V \leq V_{CC} \leq 2.7 V)

Characterist	tics	Symbol	Test C	Test Condition		Min	Max	Unit			
	_										
Input voltage	H-level	V_{IH}	-	_	2.3 to 2.7	1.6	_	V			
input voltage	L-level	V _{IL}	-	_	2.3 to 2.7		0.7	V			
				$I_{OH} = -100 \mu A$	2.3 to 2.7	V _{CC} - 0.2	_				
	H-level	Voн	VIN = VIH or VIL	$I_{OH} = -6 \text{ mA}$	2.3	2.0	_				
			IoH :				I _{OH} = -12 mA	2.3	1.8	_	
Output voltage				I _{OH} = -18 mA	2.3	1.7	_	V			
				I _{OL} = 100 μA	2.3 to 2.7	_	0.2				
	L-level	V _{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OL} = 12 mA	2.3	_	0.4			
				I _{OL} = 18 mA	2.3	_	0.6				
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		2.3 to 2.7	_	±5.0	μΑ			
3-state output OFF state current		loz	V _{IN} = V _{IH} or V _{IL}		2.3 to 2.7		±10.0	μА			
		102	V _{OUT} = 0 to 3.6 V		2.3 10 2.7		±10.0	μΑ			
Power-off leakage cur	rent	I _{OFF}	V_{IN} , $V_{OUT} = 0$ to 3.6 V		0		10.0	μΑ			
Quiescent supply current			V _{IN} = V _{CC} or GND		2.3 to 2.7		20.0	μА			
Quicocent supply cult	CIII.	Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6 \text{ V}$		2.3 to 2.7	_	±20.0	μΛ			



DC Characteristics (Ta = -40 to 85°C, 1.8 V \leq V_{CC} < 2.3 V)

Characterist	ics	Symbol	Test (Test Condition V _{CC} (V)		Min	Max	Unit
Input voltage	H-level	V _{IH}		_	1.8 to 2.3	0.7 × V _{CC}	_	V
Input voltage	L-level	V _{IL}		_	1.8 to 2.3	_	0.2 × V _{CC}	V
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.8	V _{CC} - 0.2	_	
Output voltage				$I_{OH} = -6 \text{ mA}$	1.8	1.4	_	V
	L-level	V _{OL}	VIN = VIH or VII	$I_{OL} = 100 \mu A$	1.8	_	0.2	
	L-level	VOL	AIM = AIH OL AIL	I _{OL} = 6 mA	1.8	_	0.3	
Input leakage current		I _{IN}	$V_{IN} = 0$ to 3.6 V		1.8	_	±5.0	μΑ
3-state output OFF state current		loz	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = 0$ to 3.6 V		1.8	_	±10.0	μА
Power-off leakage curr	rent	I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	_	10.0	μΑ
Ouises and supply support		loo	V _{IN} = V _{CC} or GND	V _{IN} = V _{CC} or GND		_	20.0	μА
Quiescent supply curre	51 IL	Icc	$V_{CC} \leqq (V_{IN},V_{OUT}) \leqq$	3.6 V	1.8	_	±20.0	μΑ

AC Characteristics (Ta = –40 to 85°C, input: t_r = t_f = 2.0 ns, C_L = 30 pF, R_L = 500 Ω) (Note 1)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
			1.8	1.5	5.0	
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	1.0	3.0	ns
	t _{pHL}		3.3 ± 0.3	8.0	2.5	
	+		1.8	1.5	7.5	
3-state output enable time	t _{pZL} t _{pZH}	Figure 1, Figure 3	2.5 ± 0.2	1.0	4.9	ns
			3.3 ± 0.3	8.0	3.8	
	+		1.8	1.5	5.5	
3-state output disable time	t _{pLZ}	Figure 1, Figure 3	2.5 ± 0.2	1.0	4.2	ns
			3.3 ± 0.3	8.0	3.7	
Output to output skew	+		1.8		0.5	
	t _{osLH} t _{osHL}	(Note 2)	2.5 ± 0.2	_	0.5	ns
			3.3 ± 0.3		0.5	

Note 1: For $C_L = 50$ pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design. $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, \, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$



Dynamic Switching Characteristics (Ta = 25°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

Characteristics	Symbol	Test Condition	V 00	Тур.	Unit
			V _{CC} (V)		
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	1.8	0.25	
Quiet output maximum dynamic V _{OL}	V _{OLP}	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	2.5	0.6	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	3.3	0.8	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	1.8	-0.25	
Quiet output minimum dynamic V _{OL}	Volv	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	2.5	-0.6	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	3.3	-0.8	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	1.8	1.5	
Quiet output minimum dynamic V _{OH}	V _{OHV}	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	2.5	1.9	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	3.3	2.2	

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

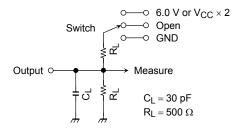
Characteristics	Symbol	Test Condition	ſ		Тур.	Unit
				V _{CC} (V)		
Input capacitance	C _{IN}			1.8, 2.5, 3.3	6	pF
Bus I/O capacitance	C _{I/O}			1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	$f_{IN} = 10 \text{ MHz}$	(Note)	1.8, 2.5, 3.3	20	pF

Note: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC \text{ (opr)}} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 \text{ (per bit)}$

AC Test Circuit



Parameter	Switch		
t _{pLH} , t _{pHL}	Open		
t _{pLZ} , t _{pZL}	6.0 V V _{CC} × 2	$@V_{CC} = 3.3 \pm 0.3 \text{ V} \\ @V_{CC} = 2.5 \pm 0.2 \text{ V} \\ @V_{CC} = 1.8 \text{ V}$	
t _{pHZ} , t _{pZH}	GND		

Figure 1

AC Waveform

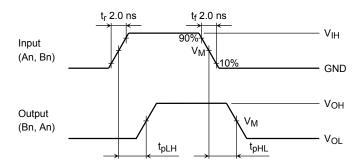


Figure 2 t_{pLH}, t_{pHL}

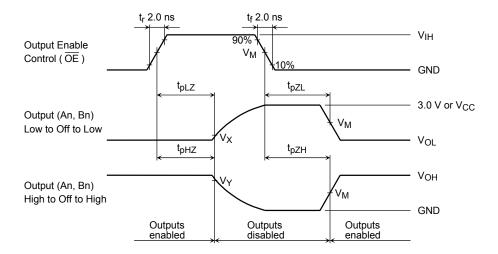


Figure 3 $\;t_{\text{pLZ}},\,t_{\text{pHZ}},\,t_{\text{pZL}},\,t_{\text{pZH}}$

Symbol	V _{CC}						
Gymbol	$3.3\pm0.3~\textrm{V}$	$2.5\pm0.2~\textrm{V}$	1.8 V				
VIH	2.7 V	Vcc	Vcc				
V _M	1.5 V	V _{CC} /2	V _{CC} /2				
VX	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V				
V_{Y}	$V_{OH} - 0.3 V$	V _{OH} – 0.15 V	V _{OH} – 0.15 V				

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Package Dimensions

TSSOP48-P-0061-0.50A Unit: mm 6.1 ± 0.1 8.1 ± 0.2 $0.2^{\,+0.07}_{\,-0.06}$ 0.5 0.5TYP |0.1M 12.8MAX 12.5 ± 0.1 1.0±0.05 0.1±0.05 <u>/</u>/20.1 0.25 (0.5)0.45~0.75

Weight: 0.25 g (typ.)

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20070701-EN

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